# imall

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We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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## **Battery Analyzers** BA6010 Series





The BA6010 Series battery analyzers measure voltage and resistance of modern battery technologies with high accuracy, resolution, and speed. Additionally, these instruments provide auxiliary measurement parameters inductance, dissipation factor, impedance, quality factor, reactance, phase angle in degrees, and capacitance in farads.

The BA6010 Series is suitable for characterizing battery chemistries that are responsive to a 1 kHz AC stimulus signal, including lead acid, lithium and alkaline type batteries used in consumer products, electric vehicles, power backup, security, and fire alarm systems. Model BA6011 supports voltage measurements of battery packs up to 300 V whereas the BA6010 features a 6 V measurement range ideal for battery cell testing. The handler and remote interfaces expands the analyzer's application to R&D and automated manufacturing environments.

#### Features & Benefits

- 4.3 inch color LCD display
- Trace function for graphical display of voltage and resistance with on-screen cursor measurements
- 4-wire kelvin test leads with fault monitoring of drive and sense lines
- Compare and sort using 9 bins with statistical evaluations
- Δ% mode for quickly determining the percent difference between batteries
- Pass/Fail indicator with audible tone
- Fast test speed up to 50 measurements per second to increase manufacturing throughput
- Trigger modes internal, manual, bus and external
- IO0 internal and external storage locations for setup and screen save
- Handler interface for easy integration with a component handler or integration with PLC
- Standard RS232, USB (USBTMC and virtual COM) interfaces

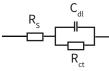
Model	Input voltage range	Basic voltage accuracy	Voltage resolution
BA6010	6 V / 60 V	0.05 %	100 µV
BA60II	30 V / 300 V	0.05 %	I mV

#### Wide range of measurements

Two user-selected measurements can be displayed simultaneously, along with stimulus signals Vm and Im. Unlike comparable battery testers that only support voltage and resistance measurements, users can also characterize additional parameters such as battery capacitance thus providing additional insight into a battery's condition.





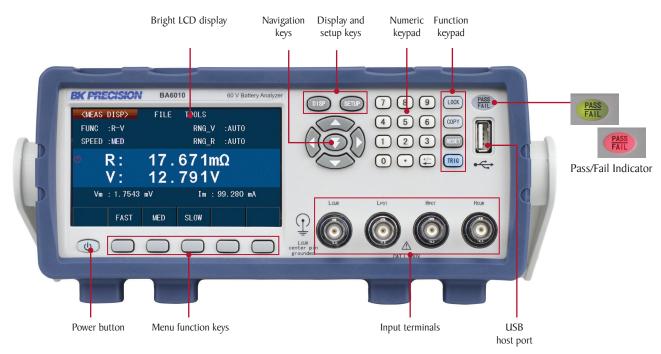


Simplified Randles cell

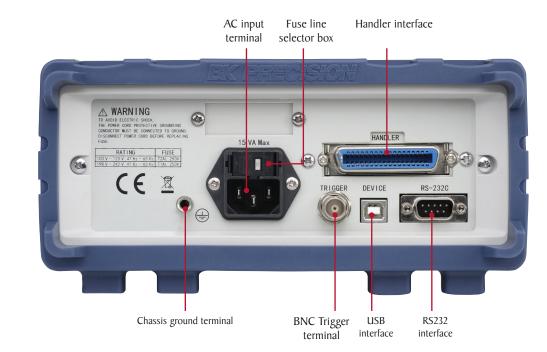


Auxiliary measurement parameters

### **Front panel**



Large 4.3 inch color LCD screen for easy viewing of configuration and measurements. 4-terminal front panel connection and quick connect test fixture for high accuracy measurements.



## **Rear panel**

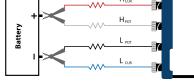
Standard RS232, USB (USBTMC and virtual COM) interfaces, handler interface and external BNC trigger input are useful for production automation.

## **Flexible operation**

#### Improved measurement accuracy

The 4-terminals on the front of the BA6010 Series are used together with the Kelvin clip test fixture. This system minimizes the influence of the test lead resistance and improves measurement accuracy.





4-wire kelvin connection

On screen monitoring system detects test probe contact failure and damaged leads for reliable measurements.



Error: HI drive open Error: LO drive open Error: HI sense open Error: LO sense open Error: Measure line open

#### **Binning function**

Quickly sort components using up to 9 bins. The bin results are displayed on-screen with each cycle. The handler interface includes dedicated signal pins for each bin, Pass/Fail and end of measurement. The handler interface is suitable for integration with device handler systems or programmable logic controllers (PLC) used in production automation.

< E	3IN -	SETUP>	FILE	
MO	DE :	ABS	COMP_A: C	N .
NO	M_A:	0Ω	NOM_B : 0	uV
B I 1	N	HIGH_A 5m	[Ω] LOW_A[Ω] 2m	HIGH_E 14
2		Sm 8m	2111 6m	13.8
3		10m	9m	13.6
4		12m	11m	13
5		14m	13m	12.8
6	<b>K</b> BIN	DISP>	FILE TOOLS	6
7	MODE	: BIN	SOUND	: NG
8 9	COMP	: ON		
	Ð	BIN:	5	
		R: 9.834m	Ω V: 12	2.271 V
	Screer			
		MEAS DISP	BIN TRACE DISP DISP	STAT DISP
		Ring for	sorting devices	

Bins for sorting devices

#### **Statistical function**

The analyzers can perform statistical calculations on the measurements and display the results on-screen.

<stat di<="" th=""><th>SP&gt;</th><th>FILE</th><th>T00</th><th>)LS</th><th></th><th></th><th>8</th></stat>	SP>	FILE	T00	)LS			8
MODE ABS	NOM_	A NO	NOM_B		STATUS ON		TATIS A
NUMBER 35	HI [H] O		L0[H] 0		IEAN		STDEV
SASTDEV	Cp	C	CpK		(num)	Ŀ	o(num)
IN (NUM)	MAX	MAXI	NDEX	MIN		MI	NINDEX
Screen copy							
	MEAS DISP	BIN TRACE STAT DISP DISP DISP					
	Statistical tools menu						

#### **Comparator function**

The comparator function evaluates measurements against a user specified upper and lower limit for pass/fail (Go/No Go) style testing. Comparative evaluations can be made using primary, secondary or both measurements. The front panel PASS / FAIL indicator will illuminate and a sounder can be enabled for audible confirmation.



#### **Trace function**

The trace function samples and plots two user-selected measurement readings over a specified time. Enable cursors for viewing plotted values and time stamp information.



Trace display

## **Specifications**

All specifications apply to the unit after a temperature stabilization time of 15 minutes over an ambient temperature range of 20 °C  $\pm$  5 °C. Specifications are subject to change without notice.

Μ	lodel	BA6010, BA6011	
Measurement Main		V, R	
Parameters	Auxiliary	L, C, D, Z, X, Q, θd, and θr	
Test I	Frequency	I kHz ± 0.2 Hz	
Display	Resolution	5 digits (SLOW & MED), 4 digits (FAST)	
Measure	ement Speed	SLOW, approx. 6.25 measurements/sec MED, approx. 10 measurements/sec FAST, approx. 50 measurements/sec	
Temperature	Voltage Meas.	0.005 % / °C	
Coefficient	Resistance Meas.	0.05 % / °C	
Tri	ggering	Internal, External, Manual, Bus	
Del	ay Time	On / Off, 0 ms to 60 s	
Ave	eraging	I to 255 samples	
Statistical Calculations		Valid data count, Invalid data count, Mean, Maximum, Minimum, Standard Deviation, Sample Standard Deviation, Process Capability Index (Dispersion), Process Capability Index (Deviation)	

Voltage Measurement (BA6010)				
SLOW, MED				
Range	Maximum Display Value	Resolution	Accuracy	
6 V	6.5000 V	I00 μV		
60 V	65.000 V	I mV	±(0.05 % FS)	

FAST				
Range	Maximum Display Value	Resolution	Accuracy	
6 V	6.500 V	I mV		
60 V	65.00 V	I0 mV	±(0.1 % FS)	

Voltage Measurement (BA6011)				
SLOW, MED				
Range	Maximum Display Value	Resolution	Accuracy	
30 V	35.000 V	I mV		
300V	310.00 V	I0 mV	±(0.05 % FS)	
FAST				
Range	Maximum Display Value	Resolution	Accuracy	

I0 mV

100 mV

35.00 V

310.0 V

±(0.1 % FS)

30 V

300 V

## **Specifications**

		Resistance Me	asurement		
LOW, MED					
Range	Maximum Display Value	Resolution	Measurement Current	Accuracy	
$30 \text{ m}\Omega$	33.000 mΩ	Ι μΩ	100 mA (± 10 %)		
$300 \text{ m}\Omega$	330.00 mΩ	10 μΩ	100 mA (±10 %)		
3 Ω	3.3000 Ω	100 μΩ	10 mA (± 10 %)		
30 Ω	33.000 Ω	lmΩ	I mA (± 10 %)	±(0.3 % + 0.1 % FS)	
300 Ω	330.00 Ω	10 mΩ	100 µA (± 10 %)		
3 kΩ	3.5000 kΩ	100 mΩ	10 μA (± 10 %)		
AST					
Range	Maximum Display value	Resolution	Measurement Current	Accuracy	
$30 \text{ m}\Omega$	33.00 mΩ	10 μΩ	100 mA (± 10 %)		
300 mΩ	330.0 mΩ	100 μΩ	100 mA (± 10 %)		
3 Ω	3.300 Ω	lmΩ	10 mA (± 10 %)		
30 Ω	33.00 Ω	10 mΩ	I μA (± 10 %)	±(0.5 % + 0.3 % FS)	
300 Ω	330.0 Ω	100 mΩ	100 µA (± 10 %)		
3 kΩ	3.500 kΩ	IΩ	10 μA (± 10 %)		

Accuracy of Auxiliary Measurement Parameters		
L, C, D, Z, X, Q, θd, and θr 5 % typical**		

\*\* see user manual for more details

n Comparat	or Function		
Limit Setting Mode		Tolerance (TOL) or Absolute (ABS) value	
Numb	per of Bins	9 sorting bins BINI-BIN9	
Веер	Warning	OFF, PASS, FAIL	
race Function	n		
Tot	tal Time	l s - 99999 s	
Sampli	ing Interval	l s - 86400 s	
eneral			
	Instrument Settings		
Save/	Save / Recall	Internal or External Memory: Up to 100	
Recall Measurements, I		Bin Comparator Results, Screenshots	
	Save	External Memory: Up to 100	
Remot	te Interface	USBTMC / USB (Virtual COM), RS232,	
D	Visplay	4.3", 480 × 272 LCD display	
AC Input		110 V ±10 % or 220 V ± 10 %, 47 to 63 Hz	
Power Consumption		IS VA Max.	
Operating Temperature		0 °C to 40 °C	
Storage	Temperature	-10 °C to 70 °C	
Relative Humidity		idity up to 80 %	

Included Accessories

Dimension (W×H×D)

Weight

User manual (downloadable), power cord, 4-wire kelvin clip test fixture (TLKBI), certificate of calibration & test report

9.25" x 4.1" x 14.17" (235 x 104 x 360 mm)

7.9 lbs (3.6 kg)

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